Please type a plus sign	ı (+) inside this box		OCT 0 1 2002	FICE VS		
Substitute for for	m 1449A/PTO	1			Complete if Known	
			TEAT & TRADER	Application Number	09/855,388	
INFORMAT	ION DISCLOS	SURE		Filing Date	5/15/01	
STATEMEN	T BY APPLIC	ANT		First Named Inventor	Reed, John Douglas et al.	
1				Group Art Unit	2681	
(use as many shee	its as necessary)			Examiner Name		
Sheet	1	Of	1	Attorney Docket Number	PF02077NA	

		Į.		U. S. PATENT DOCUMENTS				
Examiner Cite No. 1			Code <sup>2</sup>	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages o Relevant Figures Appear		
Try		4,734,779	T	Levis et al.	03-29-1988			
py		4,800,376		Suga et al.	01-24-1989			
RY		5,771,072	Î	Tokoro et al.	06-23-1998			
pyl		5,956,000		Kreitman et al.	09-21-1999			
M		6,020,890		Kohda	02-01-2000	RECEIVED		
RY		6,072,476		Harada et al.	06-06-2000			
By		6,088,005		Walls et al.	07-11-2000	UCT 0.3 2002		
RI		6,232,932	B1	Thorner	05-15-2001			
Rg		6,262,695	Bl	McGowan	07-17-2001	chnology Center 2000		
py		6,333,750	B1	Odryna et al.	12-25-2001			
jerg		6,327,482	Bl	Miyashita	12-04-2001			
py		6,331,840	B1	Nielson et al.	12-18-2001			
RJ		US2002/0021258	Al	Koenig	02-21-2002			

	I as				ON PATENT DOCUMENTS	I Date of	I Bassa Columna Linea	Т 6	
Examiner Cite No. 1		Office <sup>3</sup>	Foreign Patent Doc Number <sup>4</sup>	Kind Code <sup>2</sup> (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
Ry			JP2-211495	A	Natori	08-22-1990			
	<del>                                     </del>								
		-			· · · · · · · · · · · · · · · · · · ·				
		1							

Examiner Signature	Ryan	Yang	Date Considered	8/14/2003				
EXAMINER: Initia	al if reference considered,	whether of not citation is in conformance with MPEP 609	Draw line through	citation, if not in conformance and not considered. Include				
copy of this form with next communication to applicant.								

611/07

<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> See Kinds of U.S. Putent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English Language Translation is attached.

Form PTO 1449										
LIST OF ART CITED BY APPLICANT										
ATTY. DOCKET NO.			SERIAL NO.			FILING DATE				S S
PF02077NA			To Be Assigned			Herewith				
APPLICANT						GROUP				
		Reed	l, et al.	TENT DOOL	INSTALTO	ļ				
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAM	E	CLASS SUBCLA		FILING DATE		DATE
	AA									
	AB									
	AC									
	AD	·		:						
		V	FOREIGN	PATENT DO	CUMENT	ΓS				
		DOCUMENT NUMBER	DATE COUNTRY			CLASS SUBCLASS		ASS	TRANSLATION YES NO	
	ВА									
	BB									
		/Ir		HER PRIOR		e Etc.)				
Ry	(Including Author, Title, Date, Pertinent Pages, Etc.)  Lijun Yin et al., MPEG4 Face Modeling using Fiducial Points, IEEE, pp. 109-112, July 1997,  CA USA									
Ry	СВ	Hai Tao et al., Modeling Spatial-Temporal Patterns in Facial Articulation, IEEE, July 1997, USA								
ry	СС	Kin Choong Yow et al., Detection of Human Faces Under Scale, Orientation, and Viewpoint Variations, IEEE, September 1996, USA								
RJ.	CD	Henry A. Rowley et al., Neural Network-Based Face Detection, IEEE, 1996 USA								
EXAMINER										
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant										